

<b>Notice of References Cited</b>	Application/Control No. 10/566,258		Applicant(s)/Patent Under Reexamination YANO ET AL.	
	Examiner Martin J. Angebranndt		Art Unit 1795	Page 1 of 1

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*	C	US-2008/0033179 A1	02-2008	Yano et al.	546/277.4
*	D	US-7,316,836 B2	01-2008	Wada et al.	428/64.1
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